

# RGT16NS65D

### 650V 8A Field Stop Trench IGBT

$V_{CES}$	650V
I <sub>C(100°C)</sub>	8A
V <sub>CE(sat) (Typ.)</sub>	1.65V
$P_D$	94W

#### Features

- 1) Low Collector Emitter Saturation Voltage
- 2) Low Switching Loss
- 3) Short Circuit Withstand Time 5µs
- 4) Built in Very Fast & Soft Recovery FRD (RFN - Series)
- 5) Pb free Lead Plating; RoHS Compliant

#### Applications

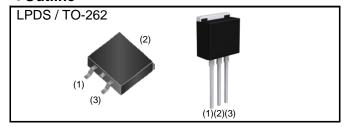
General Inverter

**UPS** 

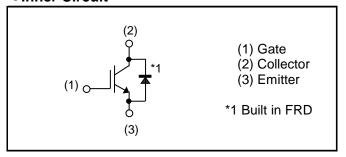
**Power Conditioner** 

Welder

#### Outline



#### ●Inner Circuit



Packaging Specifications

	Packaging	Taping / Tube
	Reel Size (mm)	330 / -
Type	Tape Width (mm)	24 / -
Type	Basic Ordering Unit (pcs)	1,000 / 1,000
	Packing code	TL / C9
	Marking	RGT16NS65D

#### ◆Absolute Maximum Ratings (at T<sub>C</sub> = 25°C unless otherwise specified)

Parameter		Symbol	Value	Unit
Collector - Emitter Voltage		V <sub>CES</sub>	650	V
Gate - Emitter Voltage		$V_{GES}$	±30	V
Callagton Cumant	T <sub>C</sub> = 25°C	I <sub>C</sub>	16	А
Collector Current	T <sub>C</sub> = 100°C	I <sub>C</sub>	8	А
Pulsed Collector Current		I <sub>CP</sub> *1 24		А
Diode Forward Current	T <sub>C</sub> = 25°C	I <sub>F</sub>	16	А
	T <sub>C</sub> = 100°C	I <sub>F</sub>	8	А
Diode Pulsed Forward Current		I <sub>FP</sub> *1	l <sub>FP</sub> *1 24	
Dawar Dissipation	T <sub>C</sub> = 25°C	P <sub>D</sub>	94	W
Power Dissipation	T <sub>C</sub> = 100°C	P <sub>D</sub>	47	W
Operating Junction Temperature		T <sub>j</sub>	-40 to +175	°C
Storage Temperature		T <sub>stg</sub>	-55 to +175	°C

<sup>\*1</sup> Pulse width limited by T<sub>imax</sub>.

#### ●Thermal Resistance

Parameter	Symbol	Values			Linit
Farameter		Min.	Тур.	Max.	Unit
Thermal Resistance IGBT Junction - Case	$R_{\theta(j-c)}$	-	-	1.58	°C/W
Thermal Resistance Diode Junction - Case	$R_{\theta(j-c)}$	-	-	3.60	°C/W

## ●IGBT Electrical Characteristics (at T<sub>j</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Conditions	Values			Unit
Parameter			Min.	Тур.	Max.	Offic
Collector - Emitter Breakdown Voltage	BV <sub>CES</sub>	$I_C = 10 \mu A, V_{GE} = 0 V$	650	1	1	V
Collector Cut - off Current	I <sub>CES</sub>	$V_{CE} = 650V, V_{GE} = 0V$	1	-	10	μΑ
Gate - Emitter Leakage Current	I <sub>GES</sub>	$V_{GE} = \pm 30V, \ V_{CE} = 0V$	ı	-	±200	nA
Gate - Emitter Threshold Voltage	$V_{GE(th)}$	$V_{CE} = 5V, I_{C} = 5.5 \text{mA}$	5.0	6.0	7.0	V
Collector - Emitter Saturation Voltage	V <sub>CE(sat)</sub>	$I_{C} = 8A, V_{GE} = 15V$ $T_{j} = 25^{\circ}C$ $T_{j} = 175^{\circ}C$	-	1.65 2.15	2.1 -	V

### ●IGBT Electrical Characteristics (at T<sub>j</sub> = 25°C unless otherwise specified)

Darameter	Symbol	Conditions		Unit		
Parameter	Symbol	Conditions	Min.	Тур.	Max.	Offic
Input Capacitance	C <sub>ies</sub>	V <sub>CE</sub> = 30V	-	450	-	
Output Capacitance	C <sub>oes</sub>	$V_{GE} = 0V$	-	21	-	pF
Reverse Transfer Capacitance	$C_{res}$	f = 1MHz	-	8	-	
Total Gate Charge	$Q_g$	V <sub>CE</sub> = 300V	-	21	-	
Gate - Emitter Charge	$Q_ge$	I <sub>C</sub> = 8A	-	6	-	nC
Gate - Collector Charge	$Q_{gc}$	V <sub>GE</sub> = 15V	-	8	-	
Turn - on Delay Time	t <sub>d(on)</sub>	$I_C = 8A, V_{CC} = 400V$	-	13	-	
Rise Time	t <sub>r</sub>	$V_{GE} = 15V, R_G = 10\Omega$	-	13	-	ns
Turn - off Delay Time	$t_{d(off)}$	T <sub>j</sub> = 25°C	-	33	-	
Fall Time	t <sub>f</sub>	Inductive Load	-	95	-	
Turn - on Delay Time	t <sub>d(on)</sub>	$I_C = 8A, V_{CC} = 400V$	-	13	-	
Rise Time	t <sub>r</sub>	$V_{GE} = 15V, R_{G} = 10\Omega$	-	14	-	200
Turn - off Delay Time	$t_{d(off)}$	T <sub>j</sub> = 175°C	-	50	-	ns
Fall Time	t <sub>f</sub>	Inductive Load	-	120	-	
		$I_C = 24A, V_{CC} = 520V$				
Reverse Bias Safe Operating Area	RBSOA	$V_P = 650 V, V_{GE} = 15 V$	FU	LL SQUA	RE	-
		$R_G = 50\Omega, T_j = 175^{\circ}C$				
		V <sub>CC</sub> ≦ 360V				
Short Circuit Withstand Time	$t_{sc}$	V <sub>GE</sub> = 15V	5	-	-	μs
		T <sub>j</sub> = 25°C				

# **•FRD Electrical Characteristics** (at $T_j = 25^{\circ}C$ unless otherwise specified)

Darameter	Symbol	Conditions	Values			Unit
Parameter			Min.	Тур.	Max.	Uniit
Diode Forward Voltage	V <sub>F</sub>	$I_F = 8A$ $T_j = 25$ °C $T_j = 175$ °C	-	1.4 1.4	1.9 -	V
Diode Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = 8A	-	42	1	ns
Diode Peak Reverse Recovery Current	I <sub>rr</sub>	$V_{CC} = 400V$ $di_F/dt = 200A/\mu s$	-	5.2	1	А
Diode Reverse Recovery Charge	$Q_{rr}$	T <sub>j</sub> = 25°C	-	0.12	-	μC
Diode Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = 8A	-	116	1	ns
Diode Peak Reverse Recovery Current	I <sub>rr</sub>	$V_{CC} = 400V$ $di_F/dt = 200A/\mu s$	-	8.1	1	А
Diode Reverse Recovery Charge	$Q_{rr}$	T <sub>j</sub> = 175°C	-	0.51	-	μC

#### • Electrical Characteristic Curves

Fig.1 Power Dissipation vs. Case Temperature

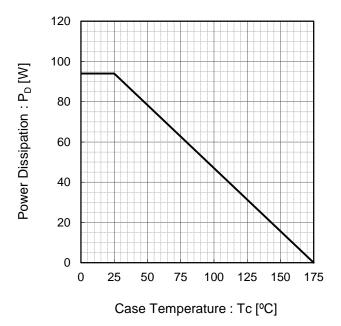


Fig.2 Collector Current vs. Case Temperature

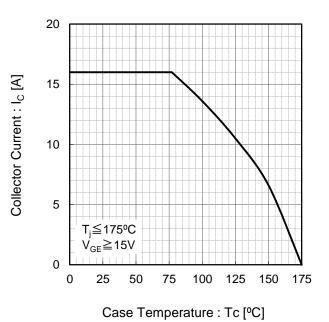
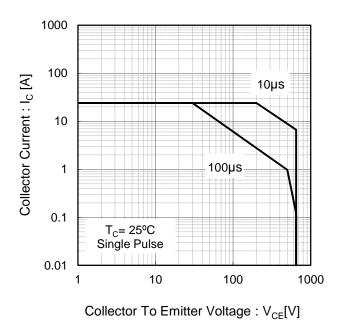


Fig.3 Forward Bias Safe Operating Area



Collector Current : I<sub>C</sub> [A]

30
25
20
15
10
5
T<sub>j</sub>≤175°C
V<sub>GE</sub>=15V
0
0 200 400 600 800

Fig.4 Reverse Bias Safe Operating Area

Collector To Emitter Voltage :  $V_{CE}[V]$ 

#### **•**Electrical Characteristic Curves

Fig.5 Typical Output Characteristics

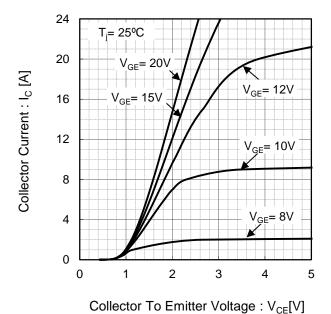
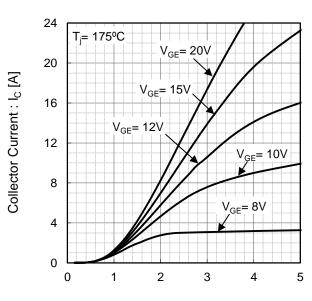


Fig.6 Typical Output Characteristics



Collector To Emitter Voltage: V<sub>CE</sub>[V]

Fig.7 Typical Transfer Characteristics

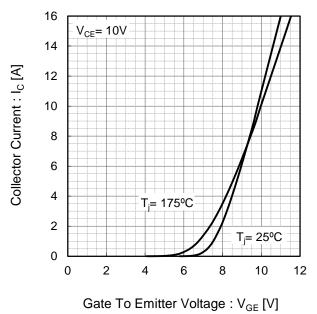
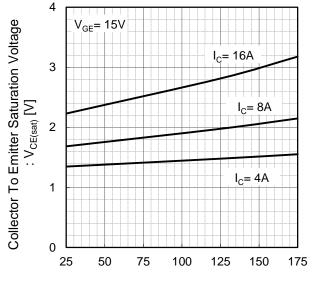


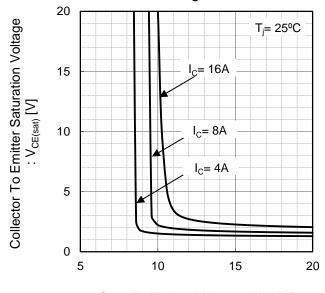
Fig.8 Typical Collector To Emitter Saturation Voltage vs. Junction Temperature



Junction Temperature : T<sub>i</sub> [°C]

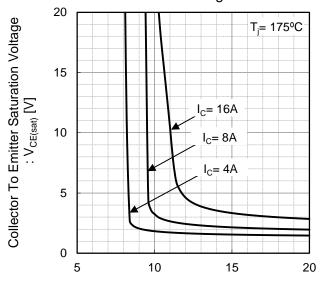
#### **•**Electrical Characteristic Curves

Fig.9 Typical Collector To Emitter Saturation Voltage vs. Gate To Emitter Voltage



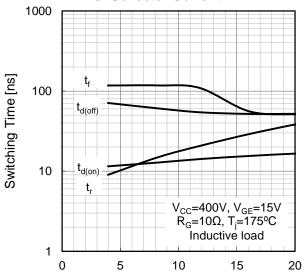
Gate To Emitter Voltage : V<sub>GE</sub> [V]

Fig.10 Typical Collector To Emitter Saturation Voltage vs. Gate To Emitter Voltage



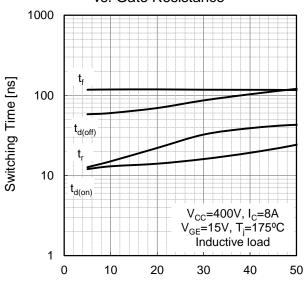
Gate To Emitter Voltage: V<sub>GE</sub> [V]

Fig.11 Typical Switching Time vs. Collector Current



Collector Current : I<sub>C</sub> [A]

Fig.12 Typical Switching Time vs. Gate Resistance



Gate Resistance :  $R_G[\Omega]$ 

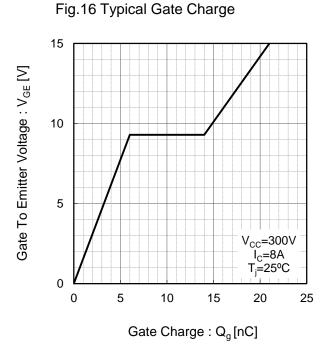
#### • Electrical Characteristic Curves

Fig.13 Typical Switching Energy Losses vs. Collector Current 10 Switching Energy Losses [mJ] 1  $\mathsf{E}_{\mathsf{off}}$ 0.1  $V_{CC}$ =400V,  $V_{GE}$ =15V  $R_{G}$ =10 $\Omega$ ,  $T_{j}$ =175°C Inductivé load 0.01 0 5 10 15 20 Collector Current : I<sub>C</sub> [A]

vs. Gate Resistance 10 Switching Energy Losses [mJ] 1  $\mathsf{E}_{\mathsf{off}}$ 0.1  $\mathsf{E}_{\mathsf{on}}$  $V_{CC}$ =400V,  $I_{C}$ =8A  $V_{GE}$ =15V,  $T_{j}$ =175°C Inductive load 0.01 0 10 20 30 40 50 Gate Resistance :  $R_G[\Omega]$ 

Fig.14 Typical Switching Energy Losses

Fig.15 Typical Capacitance vs. Collector To Emitter Voltage 10000 1000 Cies Capacitance [pF] 100 Coes 10 Cres f=1MHz  $V_{GE}=0V$ T<sub>i</sub>=25ºC 0.01 0.1 1 10 100 Collector To Emitter Voltage : V<sub>CE</sub>[V]



#### • Electrical Characteristic Curves

Fig.17 Typical Diode Forward Current vs. Forward Voltage 24 20 Forward Current : I<sub>F</sub> [A] 16 12 8 T<sub>i</sub>= 175°C 4 T<sub>i</sub>= 25°C 0 0.5 1.5 2 2.5 3

Fig.18 Typical Diode Reverse Recovery Time vs. Forward Current 160 140 Reverse Recovery Time: t<sub>rr</sub> [ns] 120 100 T<sub>i</sub>= 175°C 80 60 40  $V_{CC}$ =400V di<sub>F</sub>/dt=200A/µs T<sub>i</sub>= 25°C 20 Inductive load 0 2 4 6 8 10 Forward Current : I<sub>F</sub> [A]

Fig.19 Typical Diode Reverse Recovery Current vs. Forward Current

Forward Voltage: V<sub>F</sub>[V]

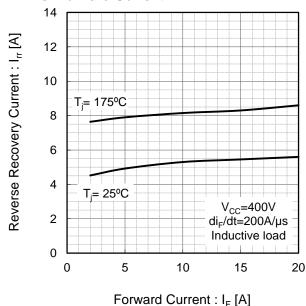
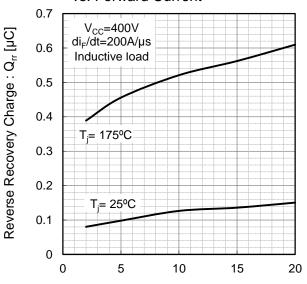
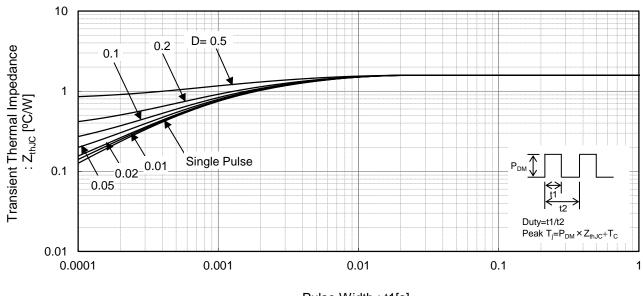


Fig.20 Typical Diode Reverse Recovery Charge vs. Forward Current



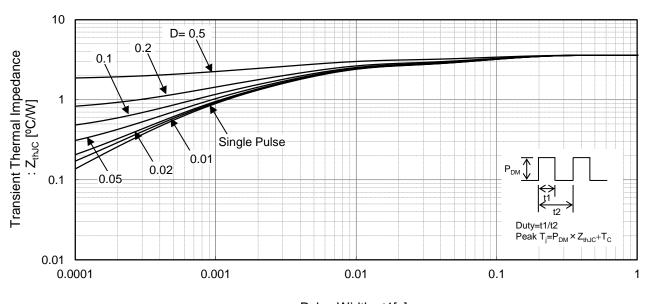
#### **•**Electrical Characteristic Curves

Fig.21 IGBT Transient Thermal Impedance



Pulse Width: t1[s]

Fig.22 Diode Transient Thermal Impedance



Pulse Width: t1[s]

### ●Inductive Load Switching Circuit and Waveform

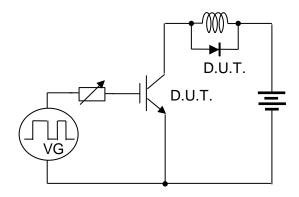


Fig.23 Inductive Load Circuit

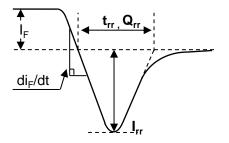


Fig.25 Diode Reverce Recovery Waveform

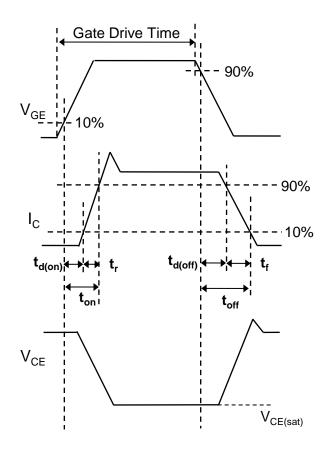


Fig.24 Inductive Load Waveform

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